

TP70H240G4PZS

700V SuperGaN® GaN FET with Slew-Rate Limiter in DPAK Package (source tab)

Description

The TP70H240G4PZS 700V, 240mΩ Gallium Nitride (GaN) FET is a normally-off switch that uses Renesas' Gen IV plus platform. It combines a state-of-the-art high voltage GaN HEMT with a low voltage silicon MOSFET to offer superior performance, standard drive, ease of adoption and reliability.

The Gen IV plus SuperGaN® platform uses advanced epi and patented design technologies to simplify manufacturability while improving efficiency via lower gate charge, output capacitance, crossover loss, and reverse recovery charge.

This product is specifically designed for flyback applications and features an integrated slew-rate limiter for improved EMI performance.

Benefits

- Superior normally off architecture with D-mode GaN HEMT
- Compatible with standard silicon drivers
- Enhanced noise immunity with high threshold voltage and no negative gate drive requirement
- No external slew rate control circuit needed
- Enables high-efficiency, high power density, and reliable power conversion in hard- and soft-switching circuits
- Low standby power consumption
- Facilitates cost-effective GaN adoption, reducing system size, weight, and costs

Features

- Ultra-fast switching Gen IV plus GaN
- JEDEC-qualified GaN technology
- Robust design, defined by:
 - Transient over-voltage capability
 - Operation with E-mode gate drivers without need for Zener protection
 - Integrated turn-on slew-rate limiter (< 4V/ns)
- Extremely low crossover loss
- Negligible Qrr
- RoHS compliant and Halogen-free packaging
- Low reverse conduction drop V_{SD}
- 2kV ESD HBM rating

Applications

- Power adapters
- Flyback Converters
- Auxiliary power supplies



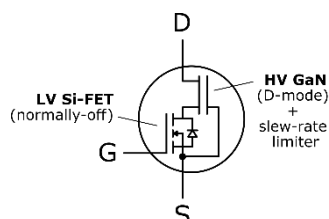
Specifications

V_{DS} (V)	700
$V_{DSS(TR)}$ (V) maximum	800
$R_{DS(on)}$ (mΩ)	240
Q_{OSS} (nC) typical	16.3
Q_G (nC) typical	5.4

Product Diagrams



TP70H240G4PZS DPAK



Cascode Device Structure

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1. Symbol Pin Information

1.1 Pin Assignments

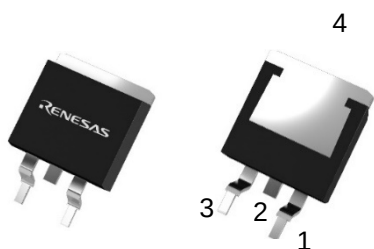


Figure 1. Pin Assignments

1.2 Pin Descriptions

Pin Number	Primary Pin Name	Primary Electrical Type	Description
1	G	Input	Gate.
2	S	-	Source.
3	D	Power	Drain.
4	S	Power	Source.

2. Specifications

2.1 Absolute Maximum Ratings

$T_c = 25^\circ\text{C}$ unless otherwise stated.

Caution: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

Symbol	Parameter	Minimum	Maximum	Test Condition	Unit
V _{DSS}	Drain to Source Voltage	-	700	V _{GS} = 0V, Test as per JEP-198	V
V _{DSS(TR)}	Transient Drain to Source Voltage	-	900	V _{GS} = 0V, ≤ 10μs, ≤ 1% Duty Cycle, cumulative 60s (60 million pulses)	
V _{DSS, pulsed}	Drain to Source Voltage, Pulsed	-	750	V _{GS} = 0V, ≤ 1μs ,≤ 1% Duty Cycle, cumulative 10h (36 billion pulses)	
V _{GSS}	Gate to Source Voltage	-20	+20	-	
P _D	Maximum Power Dissipation	-	30.2	T _C = 25° C	W
I _D	Continuous Drain Current at T _C = 25° C	-	7.8	V _{GS} = 6V, forward and reverse conduction	A
	Continuous Drain Current at T _C = 100° C	-	4.9		
I _{D(PULSE)}	Pulsed Drain Current at T _C = 25° C	-	26	V _{GS} = 6V, pulse width = 10μs	
	Pulsed Drain Current at T _C = 100° C	-	18		
I _{SD(PULSE)}	Pulsed Reverse Drain Current at T _C = 25° C	-	26	V _{GS} = 0V, pulse width = 10μs	A
	Pulsed Reverse Drain Current at T _C = 100° C	-	18		
T _J	Operating Temperature Junction	-55	+150	-	°C
T _S	Storage Temperature	-55	+150	Max shelf life depends on storage conditions	°C
T _{SOLD}	Reflow Soldering Temperature ^[1]	-	260	-	°C

1. Reflow MSL3.

2.2 Thermal Specifications

Symbol	Parameter	Typical Value	Test Condition	Unit
$R_{\theta JC}$	Junction-to-case	4.1	-	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-ambient	50	Device on $40 \times 40 \text{ mm} \times 1.5\text{mm}$ epoxy PCB FR4 with 6 cm^2 (one layer, $70\mu\text{m}$ thickness) copper area for tab (source) connection and cooling. PCB is vertical without air stream cooling.	

2.3 Electrical Specifications – Forward Characteristics

$T_J = 25^\circ\text{C}$ unless otherwise stated.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Unit
$V_{DS(BL)}$	Maximum Drain-Source Voltage	$V_{GS} = 0V$	700	-	-	V
$V_{GS(th)}$	Gate Threshold	$V_{DS} = V_{GS}, I_D = 0.5mA$	1.5	2	2.5	V
$\Delta V_{GS(th)}/T_J$	Gate Threshold Voltage Temperature Coefficient		-	-7.6	-	mV/ $^\circ\text{C}$
$R_{DS(on)eff}$	Drain-Source on-Resistance	$V_{GS} = 6V, I_D = 3A, T_J = 25^\circ\text{C}$	-	240	320	m Ω
		$V_{GS} = 6V, I_D = 3A, T_J = 150^\circ\text{C}$	-	492	-	
I_{DSS}	Drain-to-Source Leakage Current	$V_{DS} = 700V, V_{GS} = 0V, T_J = 25^\circ\text{C}$	-	1	10	μA
		$V_{DS} = 700V, V_{GS} = 0V, T_J = 150^\circ\text{C}$	-	3	-	
I_{GSS}	Gate-to-Source Forward Leakage Current ^[1]	$V_{GS} = 20V$	-	-	10	μA
	Gate-to-Source Reverse Leakage Current ^[1]	$V_{GS} = -20V$	-	-	-10	
I_{GSS}	Gate-to-Source Forward Leakage Current ^[1]	$V_{GS} = 6V$	-	-	0.1	μA
	Gate-to-Source Reverse Leakage Current ^[1]	$V_{GS} = -6V$	-	-	-0.1	
C_{ISS}	Input Capacitance	$V_{GS} = 0V, V_{DS} = 400V, f = 1MHz$	-	455	-	pF
C_{OSS}	Output Capacitance		-	15.1	-	
C_{RSS}	Reverse Transfer Capacitance		-	1	-	
$C_{O(er)}$	Output Capacitance, Energy Related ^[2]	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$	-	22.2	-	pF
$C_{O(tr)}$	Output Capacitance, Time Related ^[3]		-	40.2	-	
Q_G	Total Gate Charge	$V_{DS} = 400V, V_{GS} = 0V \text{ to } 6V, I_D = 3A$	-	5.4	-	nC
Q_{GS}	Gate-source Charge		-	1.4	-	
Q_{GD}	Gate-drain Charge		-	2.1	-	
Q_{OSS}	Output Charge	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$	-	16.3	-	nC
$t_{D(on)}$	Turn-on Delay	$V_{DS} = 400V, V_{GS} = 0 \text{ to } 6V, R_{G_on} = 100\Omega, R_{G_off} = 0\Omega, I_D = 3A$ (see Figure 15)	-	72	-	ns
t_R	Rise Time		-	85.6	-	
$t_{D(off)}$	Turn-off Delay		-	15.6	-	
t_F	Fall Time		-	9.6	-	

1. MOSFET has integrated ESD Protection Circuit
2. Equivalent capacitance to give same stored energy from 0V to 400V.
3. Equivalent capacitance to give same charging time from 0V to 400V.

2.4 Electrical Specifications – Reverse Device

$T_J = 25^\circ\text{C}$ unless otherwise stated.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Unit
V_{SD}	Reverse voltage	$V_{GS} = 0V, I_S = 3A$	-	1.6	-	V
		$V_{GS} = 0V, I_S = 1.5A$	-	1.2	-	

Note: Reverse recovery charge is negligible enabled by the LV Si FET technology.

3. Typical Performance Graphs

$T_c = 25^{\circ}\text{C}$ unless otherwise stated.

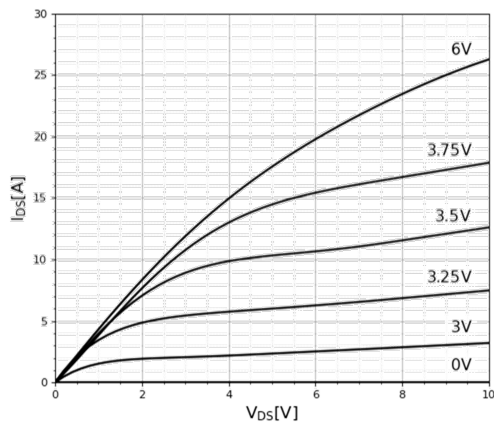


Figure 2. Typical Output Characteristics, $T_j = 25^{\circ}\text{C}$
Parameter: V_{GS}

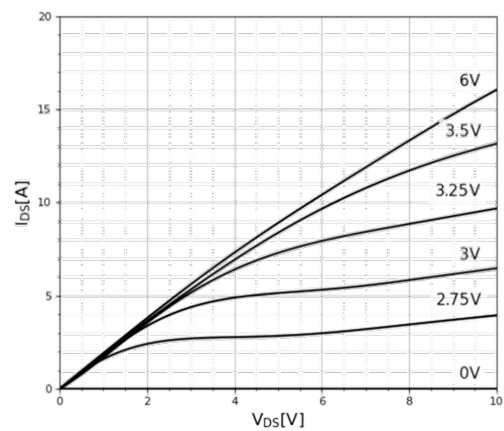


Figure 3. Typical Output Characteristics, $T_j = 150^{\circ}\text{C}$
Parameter: V_{GS}

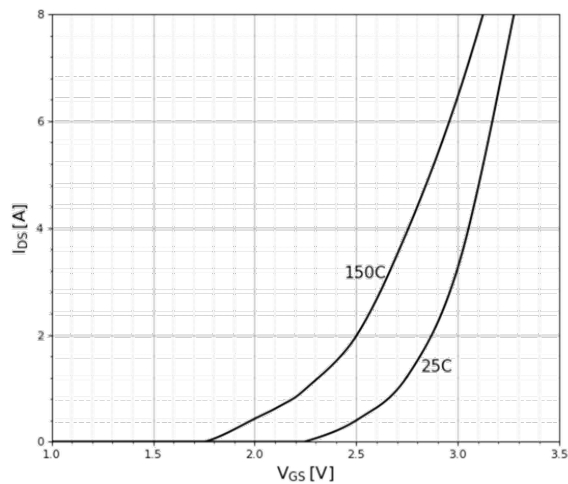


Figure 4. Typical Transfer Characteristics,
 $V_{DS} = 10\text{V}$, Parameter: T_j

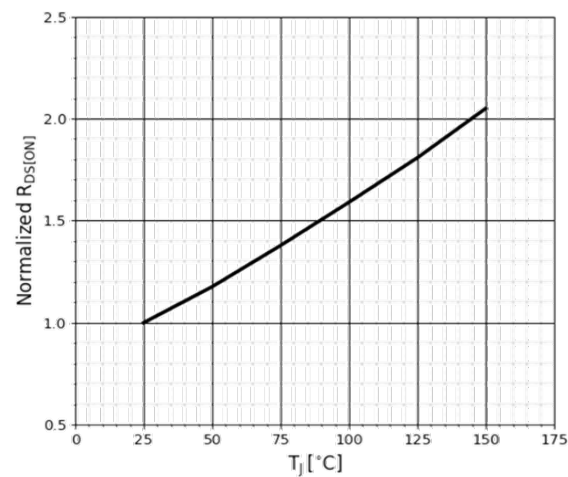


Figure 5. Normalized On-Resistance,
 $I_D = 3\text{A}$, $V_{GS} = 6\text{V}$

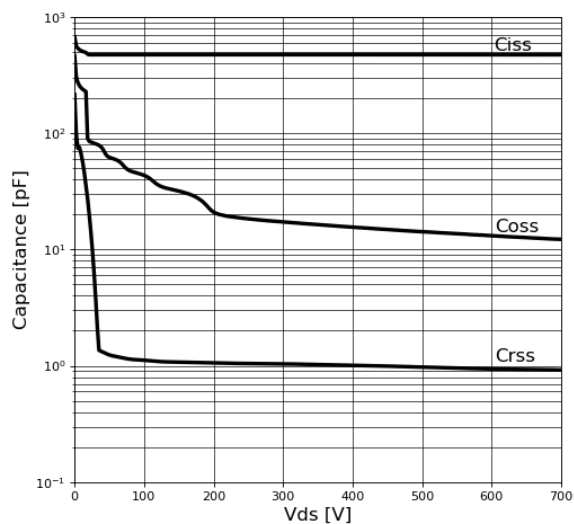


Figure 6. Typical Capacitance,
V_{GS} = 0V, f = 100kHz

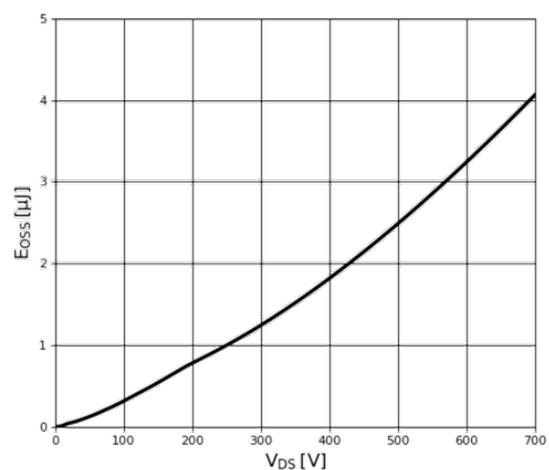


Figure 7. Typical Coss Stored Energy

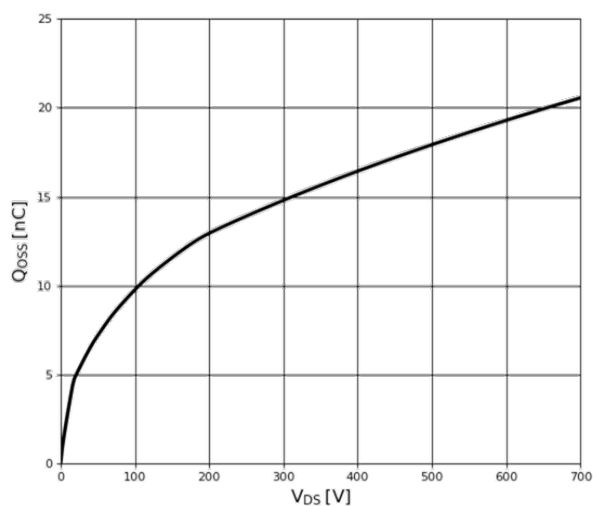


Figure 8. Typical Qoss

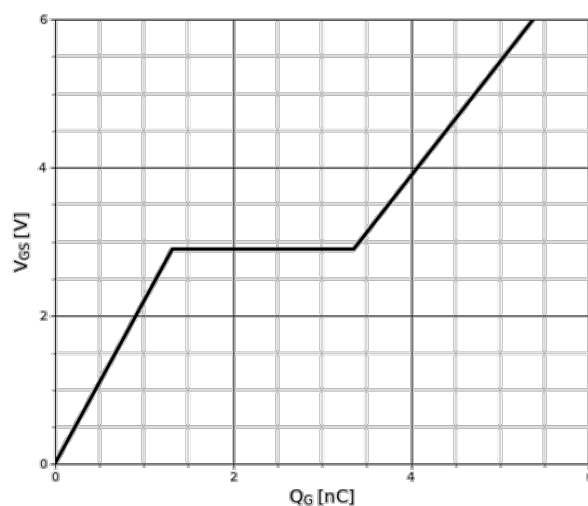


Figure 9. Typical Gate Charge,
I_{DS} = 3A, V_{DS} = 400V

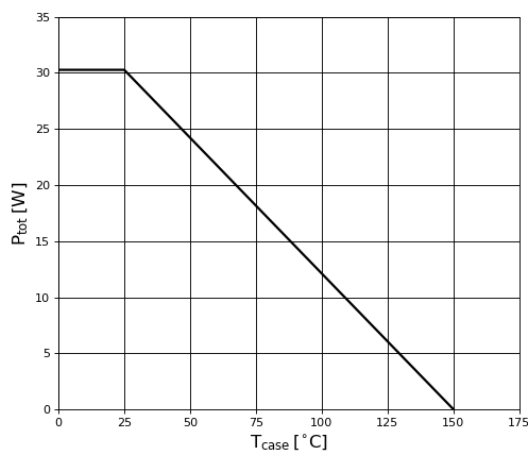


Figure 10. Power Dissipation

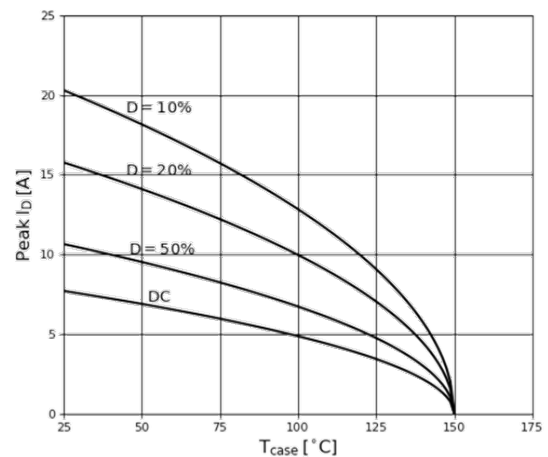


Figure 11. Current Derating,
Pulse width ≤ 10μs, V_{GS} ≥ 6V

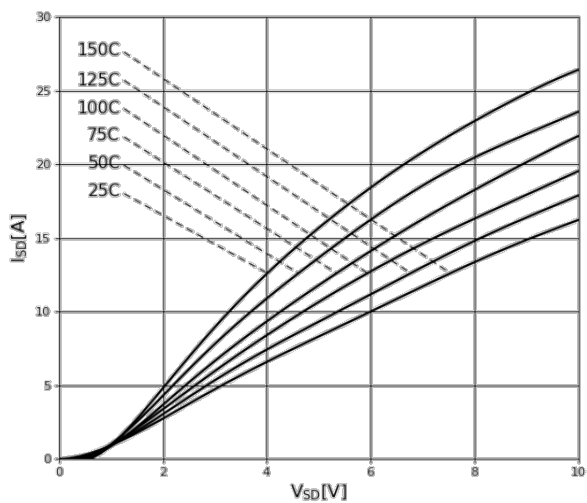


Figure 12. Forward Characteristics of Rev. Diode

$I_S = f(V_{SD})$, Parameter: T_J

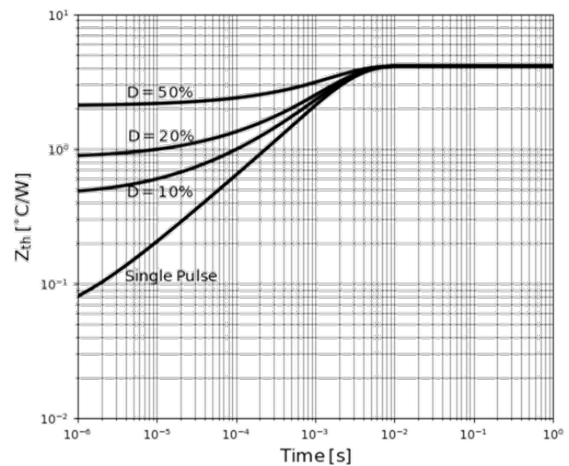


Figure 13. Transient Thermal Resistance

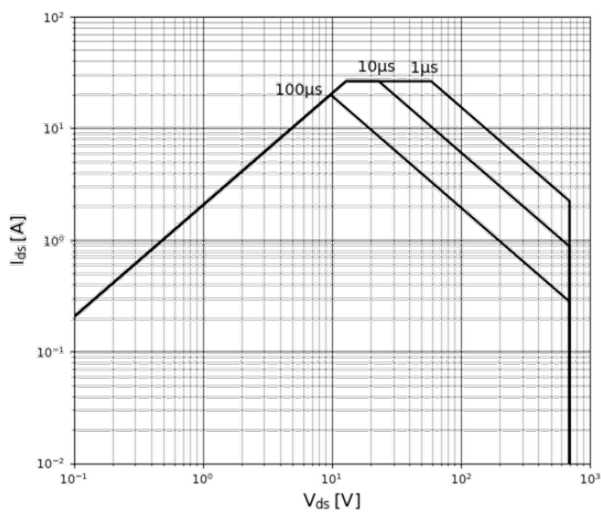


Figure 14. Safe Operating Area T_c = 25°C

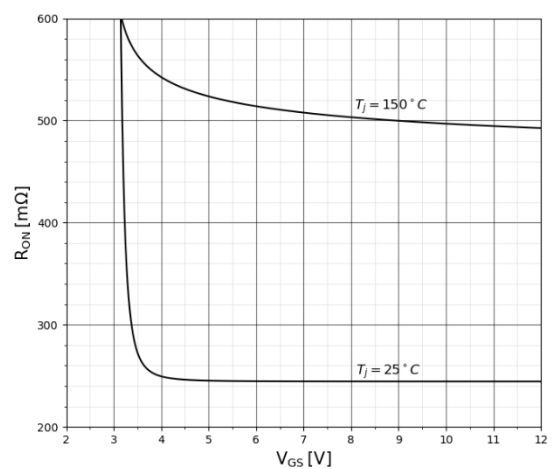


Figure 15. R_{DS(on)} = f(V_{GS}); I_D = 3A

4. Test Circuits and Waveforms

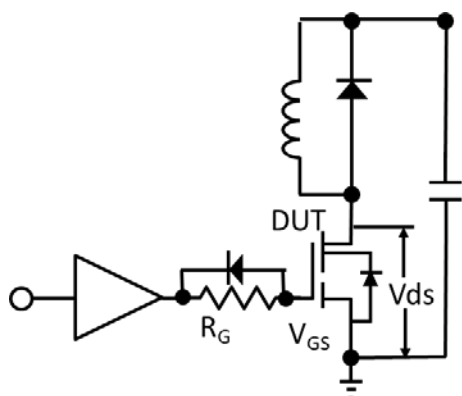


Figure 16. Switching Time Test Circuit

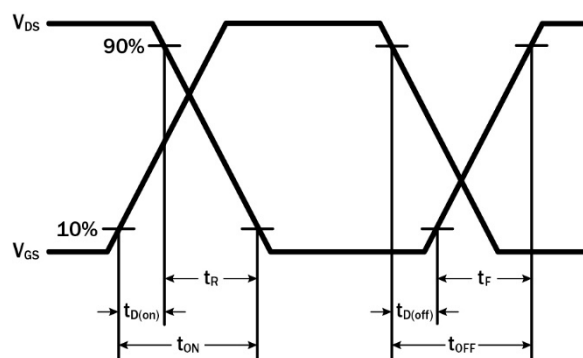


Figure 17. Switching Time Waveform

5. Package Outline Drawings

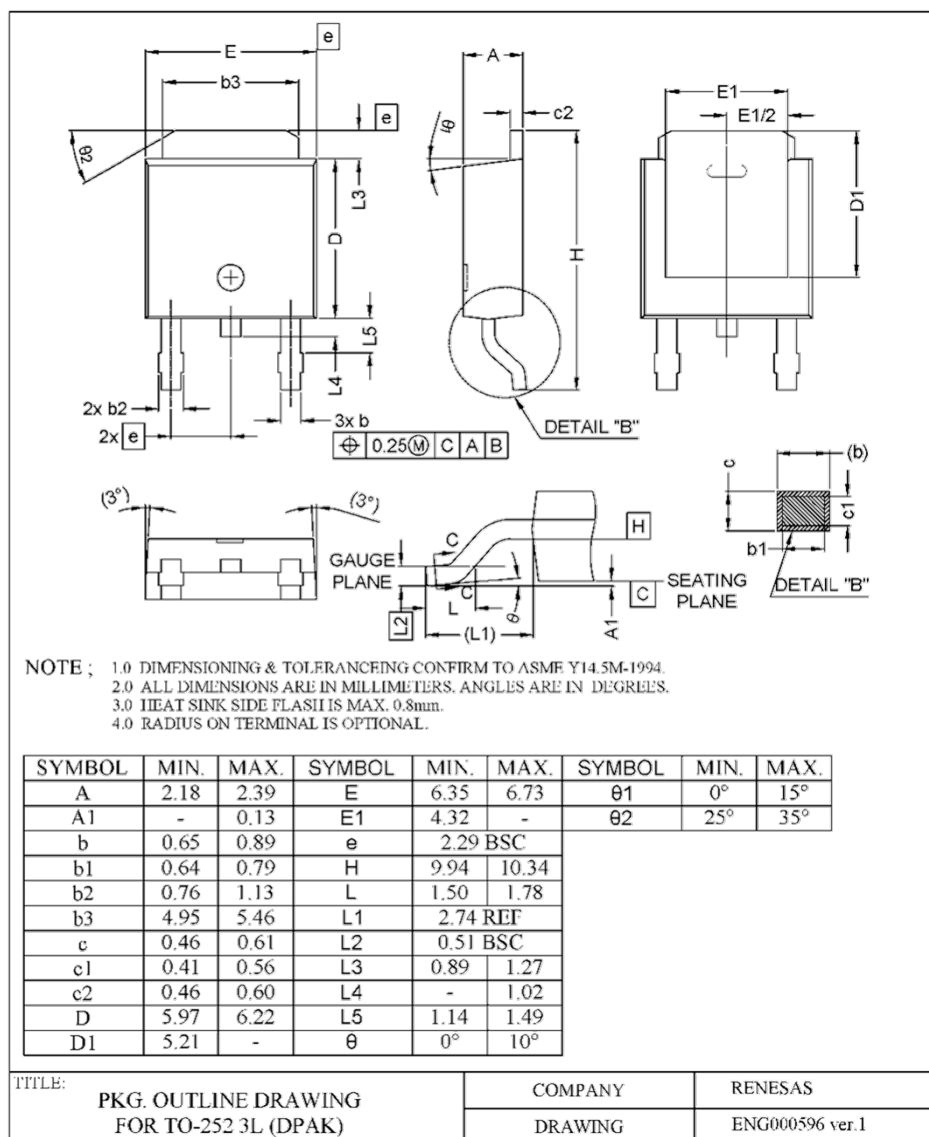


Figure 18. Package Outline Drawing – DPAK

6. Related Information

All technical documents for Renesas GaN Power devices are accessible from the [GaN Power Solutions](#) page.

7. Ordering Information

Orderable Part Number	Number of Pins	Package Type	Package Code/POD Number
TP70H240G4PZS-TR ^[1]	3	DPAK	ENG000596

1. "-TR" suffix refers to tape and reel.

8. Revision History

Revision	Date	Description
1.01	Aug 7, 2026	Minor edits and reformatting.
1.00	Jul 6, 2026	Initial release.

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